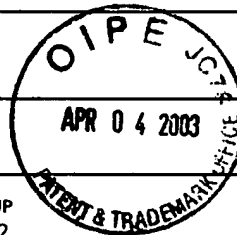


FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)

Date Submitted to PTO: April 4, 2003

ATTY DOCKET NO.
2001_1094ASERIAL NO.
09/890,455APPLICANT
Hiroaki INOUE et al.FILING DATE
March 12, 2002GROUP
2812

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
J.H.	AA	6,258,223	7/2001	Cheung et al.	204	242	
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
J.H.	AJ	07-193214	7/1995	JP			Abstract
J.H.	AK	06-349952	12/1994	JP			Abstract
	AL						
	AM						
	AN						

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

J.H.	AO	Partial English translation of Semiconductor Fundamental-Term Dictionary definitions of "minimum linewidth", "design rule" and "line and space" (1989).
	AP	
	AQ	

EXAMINER

Lynn A. Hurley

DATE CONSIDERED

10/10/03